

Enhancement Mode N-Channel Power MOSFET

SOT23-6/NMOS/16V/ \pm 12V/0.55V/4A/19m Ω

Rev_{0.6}





16V, 19mΩ, 4A, N-Channel MOSFET

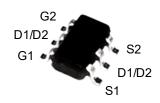
1.Features

- High Power and current handing capability
- Lead free product is acquired
- ◆ Surface Mount Package

V _{DS} Typ.	R _{DS(on)} Typ.	I _D Max.
16V	19mΩ @ 4.5V	4.0
	24mΩ @ 2.5V	4A

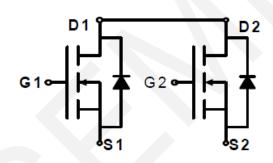
2.Applications

- Battery Protection
- Battery Powered Systems
- Power Management in Notebook Computer
- Portable Equipment



Pin Description

SOT23-6



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Part no. Marking		PCS/Reel	PCS/CTN.
WP8205C	8205 <u>A</u>	SOT23-6	3,000	180,000

3.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	16	V
Gate to Source Voltage	V _{GSS}	±12	V
Drain Current-Continuous	I _D	4	Α
Drain Current (Pulse)	I _{DM}	30	Α
Maximum Power Dissipation	P _D	1.5	W
Operating Junction and Storage Temperature Range	T _j , T _{stg}	-55 to +150	°C
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



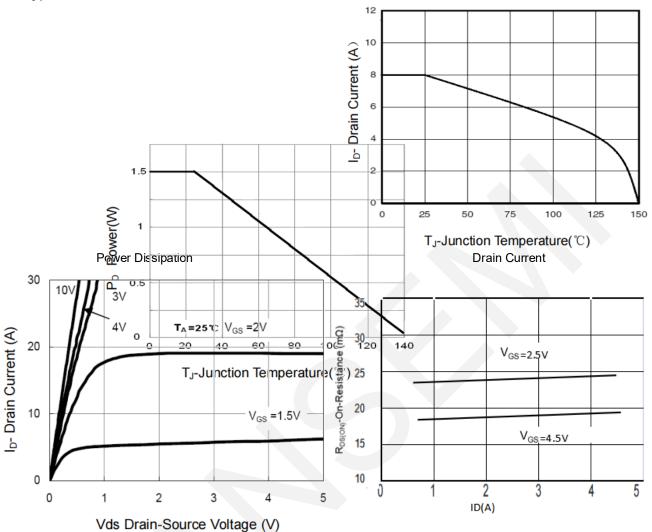
4.Electrical Characteristics at Ta=25°C (Note 2)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	16	18		V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = 12V, V _{GS} = 0V			1	μΑ
Gate-Body Leakage Current	I _{GSS}	$V_{GS} = \pm 10V, V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{DS}=250\mu A$	0.4	0.55	1.2	V
Drain to Source On-State	_	$I_D = 4A, V_{GS} = 4.5V$	-	19	24	mΩ
Resistance	R _{DS(on)}	I _D =3A, V _{GS} = 2.5V	-	24	30	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,		1150		pF
Output Capacitance	C _{oss}	V _{DS} =10V,		185		pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz		145		pF
Turn-ON Delay Time	t _{d(on)}			6		ns
Turn-ON Rise Time	t _r	$V_{DD} = 10V, I_D = 4A,$		13		ns
Turn-OFF Delay Time	t _{d(off)}	V_{GS} = 4.5V, R_{GEN} = 6Ω		52		ns
Turn-ON Fall Time	t _f			16		ns
Total Gate Charge	Q_g	V _{DS} = 10V,		15		nC
Gate-Source Charge	Q_{gs}	$V_{GS} = 4.5V$,		0.8		nC
Gate-Drain Charge	Q_{gd}	$I_D = 4A$		3.2		nC
Diode Forward Voltage	V _{SD}	I _S = 4A, V _{GS} = 0V		0.9	1.2	V

Note 2: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



5. Typical electrical and thermal characteristics

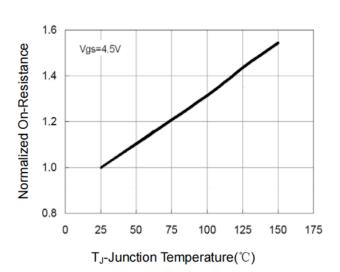


Output Characteristics

20 V_{GS}=5V 15 10 10 125°C 25°C 25°C Vgs Gate-Source Voltage (V)

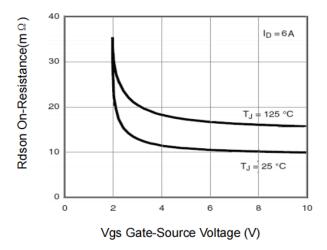
Transfer Characteristics

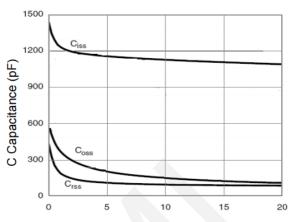
Drain-Source On-Resistance



Drain-Source On-Resistance



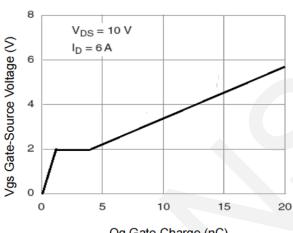


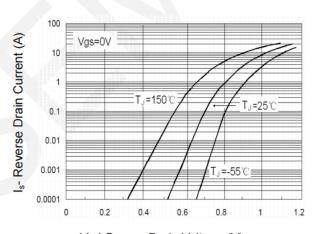


Vds Drain-Source Voltage (V)

Capacitance vs Vds

Rdson vs Vgs



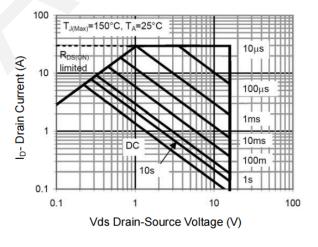


Qg Gate Charge (nC)

Gate Charge

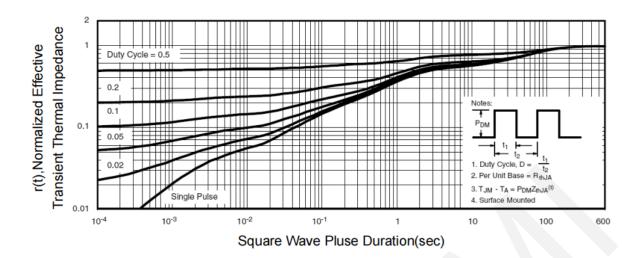
Vsd Source-Drain Voltage (V)

Source- Drain Diode Forward



Safe Operation Area



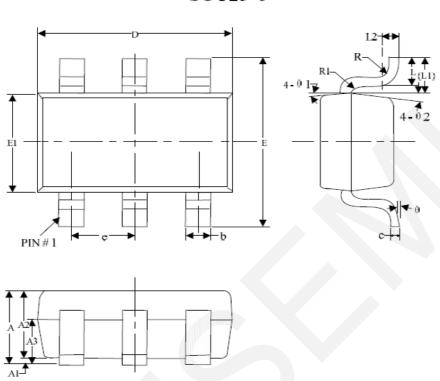


Normalized Maximum Transient Thermal Impedance



6.Package Dimensions

SOT23-6



Dimensions (unit: mm)

SYMBOL	MIN	NOM	MAX		SYMBOL	MIN	NOM	MAX
Α	-	_	1.30		е	0.85	0.95	1.05
A1	0	-	0.15		L	0.35	0.45	0.60
A2	0.90	1.10	1.30		L1	0.59REF		
A3	0.60	0.65	0.70		L2	0.25BSC		
b	0.39	-	0.49		R	0.05	-	_
С	0.12	-	0.19		R1	0.05	-	0.02
D	2.85	2.95	3.15]	θ	0°	-	8°
E	2.60	2.80	3.00	1	91	3°	5°	7°
E1	1.55	1.65	1.75		θ2	6°	8°	10°



7.Important Notice

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